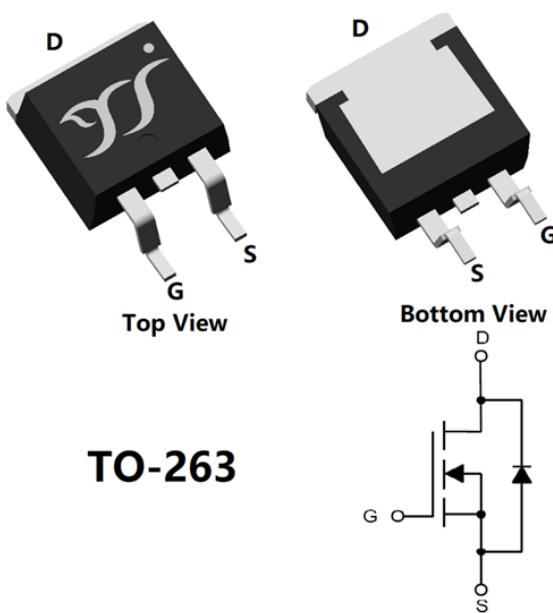




N-Channel Enhancement Mode Field Effect Transistor



Product Summary

- V_{DS} 650V
- I_D 16.5A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) $<190m\Omega$
- 100% EAS Tested
- 100% ∇V_{DS} Tested

General Description

- Super Junction High Voltage MOSFET Technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$
- Moisture Sensitivity Level 1
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Switching Mode Power Supplies (SMPS)
- PWM Motor Controls
- LED Lighting
- Adapter

■ Limiting Values

Parameter	Conditions		Symbol	Min	Max	Unit
Drain-source Voltage			V_{DS}	-	650	V
Gate-source Voltage			V_{GS}	-30	30	
Continuous Drain Current (Note 1,2)	Steady-State	$T_A=25^\circ C, V_{GS}=10V$	I_D	-	2.5	A
		$T_A=100^\circ C, V_{GS}=10V$		-	1.5	
Continuous Drain Current (Note 1,3)		$T_C=25^\circ C, V_{GS}=10V$		-	16.5	
		$T_C=100^\circ C, V_{GS}=10V$		-	10.4	
Pulsed Drain Current	$T_C=25^\circ C, t_p \leq 10\mu s$		I_{DM}	-	50	
Maximum Body-Diode Continuous Current	$T_C=25^\circ C$		I_S	-	16.5	
Maximum Body-Diode Pulsed Current	$T_C=25^\circ C, t_p \leq 10\mu s$		I_{SM}	-	50	
Avalanche Energy (non-repetitive)	$T_J=25^\circ C, V_G=10V, R_G=25\Omega, L=30mH, I_{AS}=4.6A$		EAS	-	317.4	mJ
Total Power Dissipation (Note 1,2)	Steady-State	$T_A=25^\circ C$	P_D	-	3.1	W
		$T_A=100^\circ C$		-	1.2	
Total Power Dissipation (Note 1,3)		$T_C=25^\circ C$		-	138	
		$T_C=100^\circ C$		-	55	
MOSFET dv/dt Ruggedness	$T_J=25^\circ C, V_{DS}=0...325V, I_D \leq 15.5A, R_g=0\Omega$		dv/dt	-	67	V/ns
Reverse Diode dv/dt	$T_J=25^\circ C, V_{DS}=0...325V, I_D \leq 15.5A, di/dt=200A/us$		dv/dt	-	116	
Maximum Diode Commutation Speed	$T_J=25^\circ C, V_{DS}=0...325V, I_D \leq 15.5A, R_g=0\Omega$		di/dt	-	1540	A/us
Junction and Storage Temperature Range			T_J, T_{STG}	-55	150	°C

■ Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	$R_{\theta JA}$	-	40	°C/W
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	0.9	

■ Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJB190D65CFJ	F2	YJB190D65CF	800	/	4000	13" reel



■ Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA, T _j =25°C	650	-	-	V
		V _{GS} =0V, I _D =10mA, T _j =25°C	650	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _j =25°C	-	-	10	μA
		V _{DS} =650V, V _{GS} =0V, T _j =100°C	-	-	100	
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V, T _j =25°C	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA, T _j =25°C	2.7	3.5	4.3	V
Static Drain-Source On-Resistance	R _{DSS(ON)}	V _{GS} =10V, I _D =10A, T _j =25°C	-	150	190	mΩ
		V _{GS} =10V, I _D =10A, T _j =150°C	-	390	492	mΩ
Diode Forward Voltage	V _{SD}	I _S =10A, V _{GS} =0V, T _j =25°C	-	0.88	1.2	V
Gate Resistance	R _G	f=1MHz, T _j =25°C	-	5	-	Ω
Dynamic Parameters						
Input Capacitance	C _{iss}	V _{DS} =325V, V _{GS} =0V, f=1MHz, T _j =25°C	-	1500	-	pF
Output Capacitance	C _{oss}		-	37	-	
Reverse Transfer Capacitance	C _{rss}		-	5	-	
Effective Output capacitance, Energy Related	C _{o(er)}	V _{DS} =0...325V, V _{GS} =0V, f=1MHz, T _j =25°C	-	64	-	
Effective Output Capacitance, Time Related	C _{o(tr)}		-	396	-	
Switching Parameters						
Total Gate Charge	Q _g	V _{GS} =10V, V _{DS} =325V, I _D =16.5A, T _j =25°C	-	33	-	nC
Gate-Source Charge	Q _{gs}		-	9	-	
Gate-Drain Charge	Q _{gd}		-	14	-	
Reverse Recovery Charge	Q _{rr}	I _F =16.5A, di/dt=100A/μs, V _{GS} =0V, V _R =325V, T _j =25°C	-	933	-	nC
Reverse Recovery Time	t _{rr}		-	133	-	ns
Peak Reverse Recovery Current	I _{rrm}		-	13.5	-	A
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DS} =325V, I _D =16.5A, R _{GEN} =3Ω, T _j =25°C	-	66	-	ns
Turn-on Rise Time	t _r		-	27	-	
Turn-off Delay Time	t _{D(off)}		-	32	-	
Turn-off Fall Time	t _f		-	9.5	-	

Note:

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- The value of R_{θJA} is measured with the device mounted on the 40mm*40mm*1.1mm single layer FR-4 PCB board with 1 in² pad of 2oz. Copper, in the still air environment with T_A=25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- Thermal resistance from junction to soldering point (on the exposed drain pad).

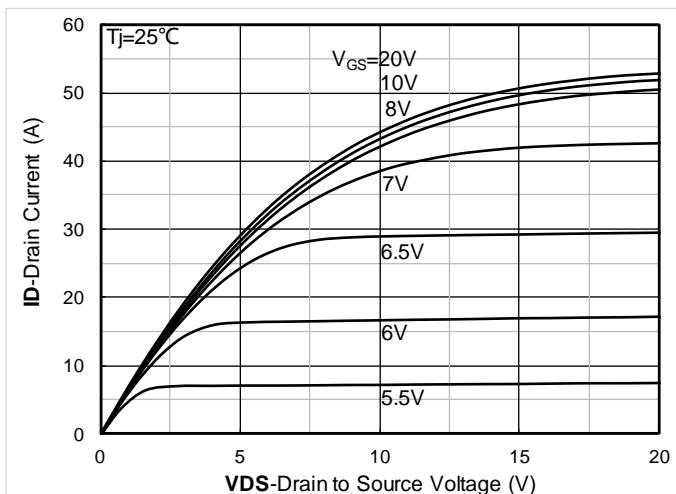
**■Typical Electrical and Thermal Characteristics Diagrams**

Figure 1. Output Characteristics; typical values

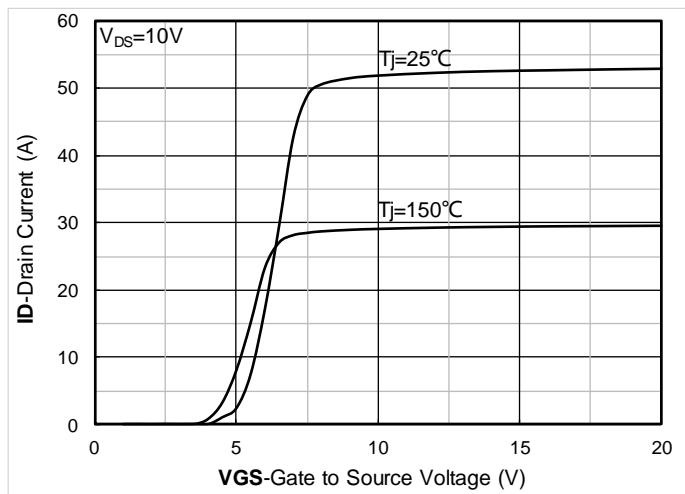


Figure 2. Transfer Characteristics; typical values

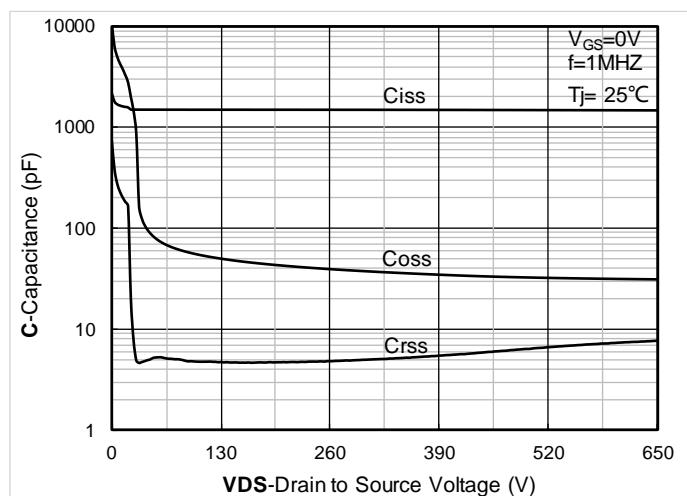


Figure 3. Capacitance Characteristics; typical values

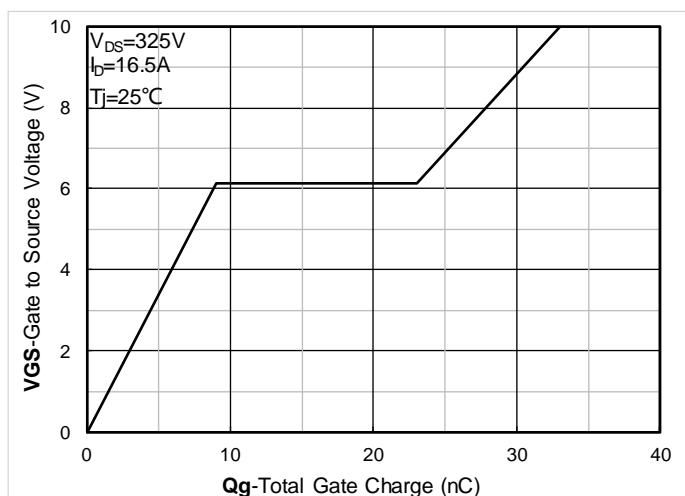


Figure 4. Gate Charge; typical values

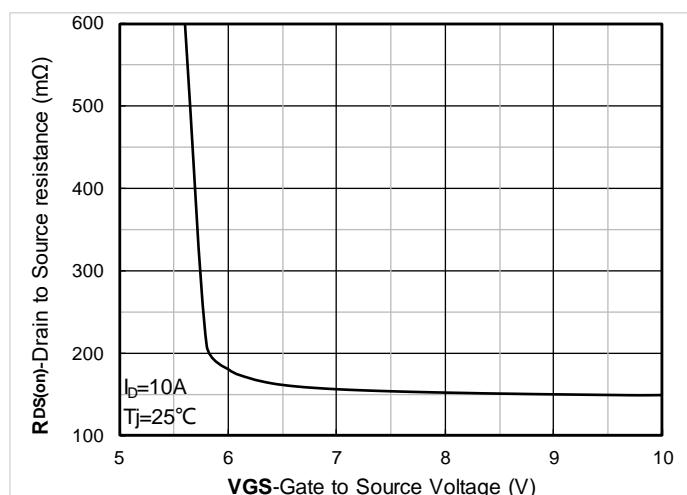


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

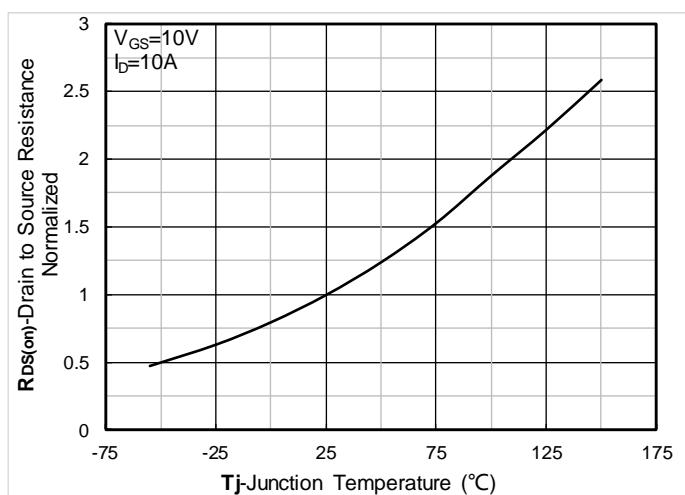


Figure 6. Normalized On-Resistance

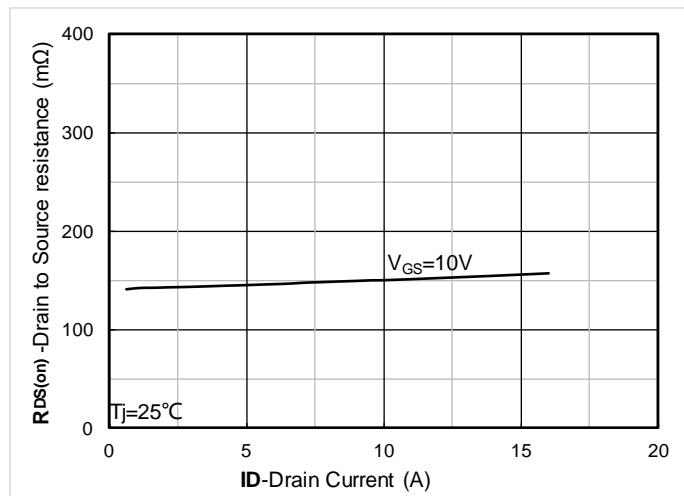
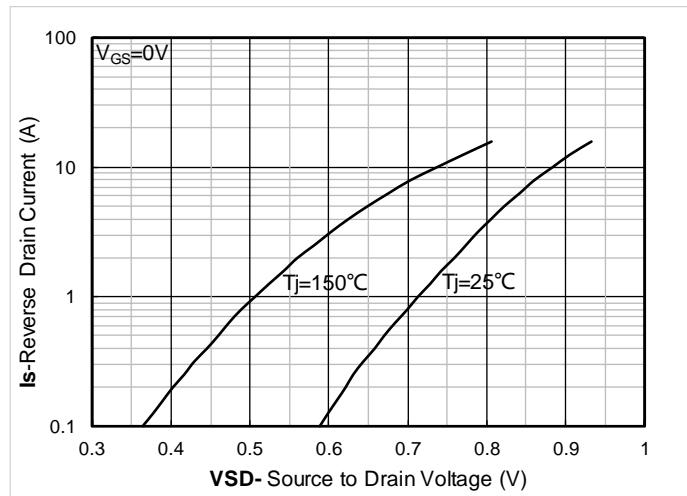
Figure 7. $R_{DS(on)}$ vs. Drain Current; typical values

Figure 8. Forward characteristics of reverse diode; typical values

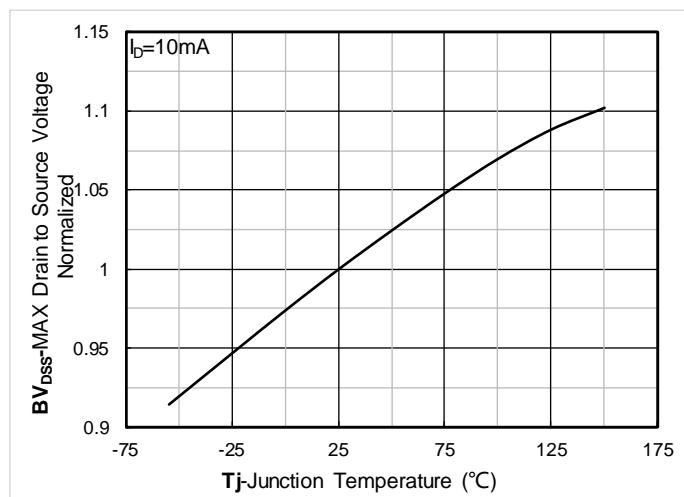


Figure 9. Normalized breakdown voltage

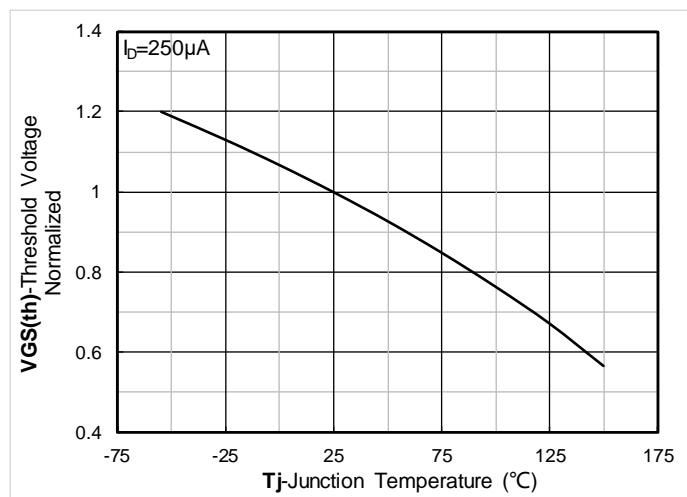


Figure 10. Normalized Threshold voltage

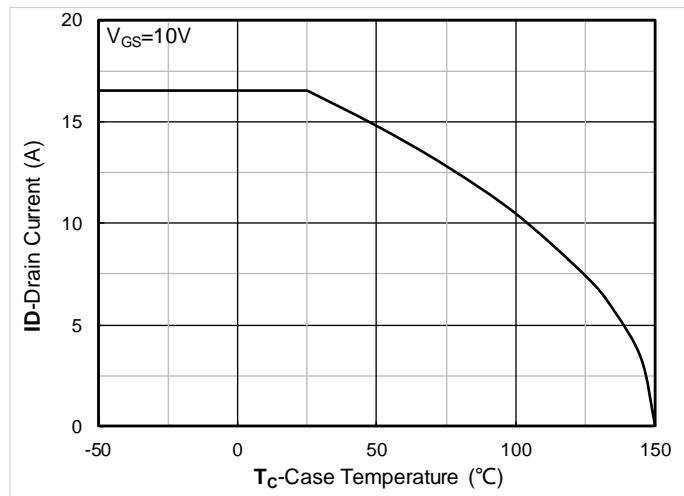


Figure 11. Current dissipation

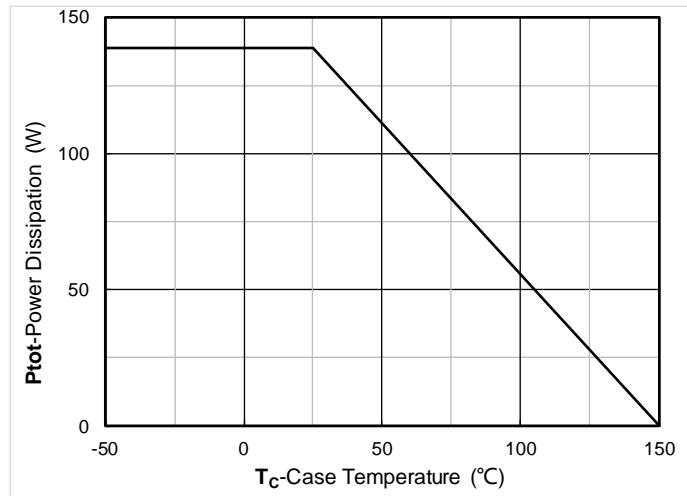


Figure 12. Power dissipation

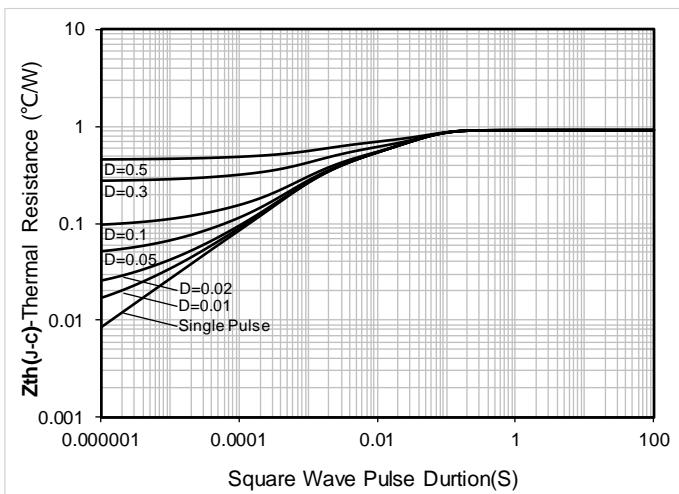


Figure 13. Maximum Transient Thermal Impedance

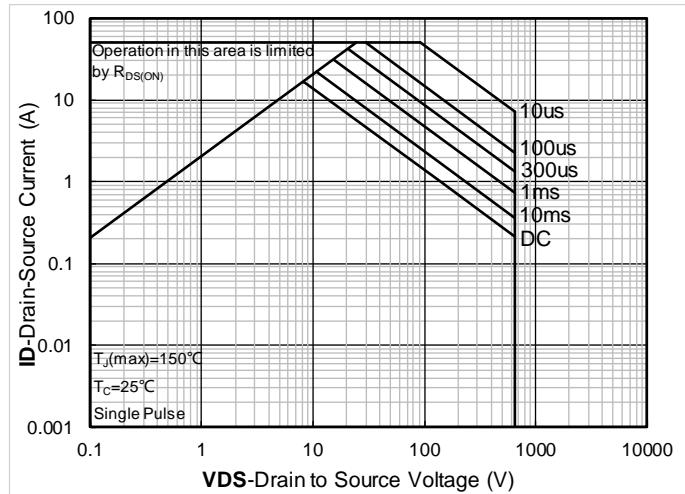


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

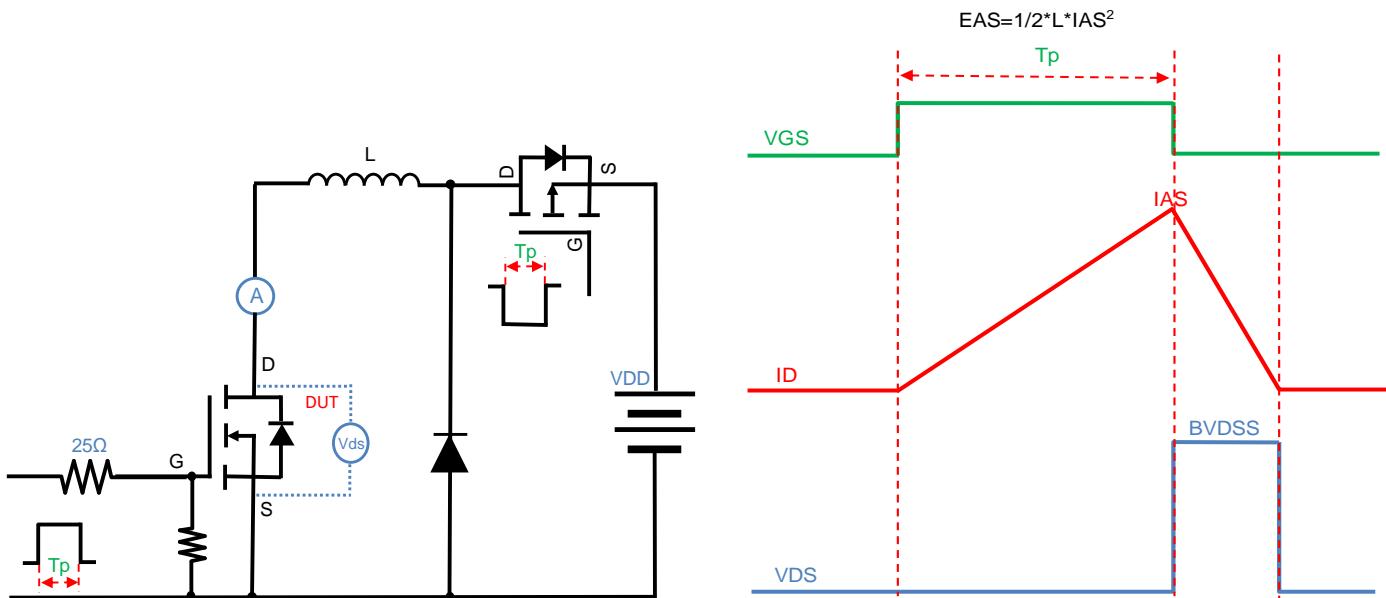


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

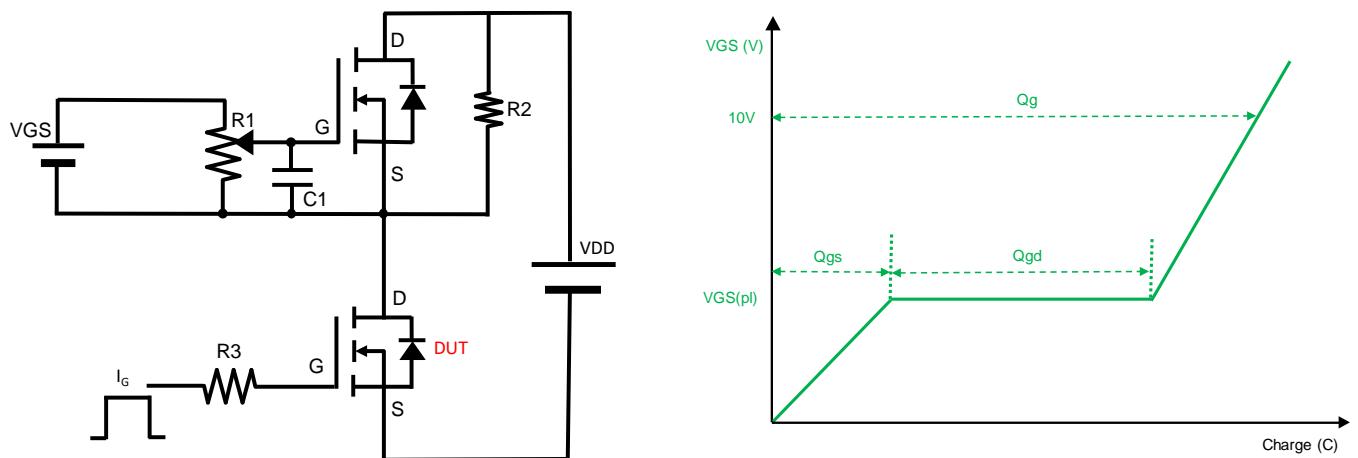


Figure B. Gate Charge Test Circuit & Waveform

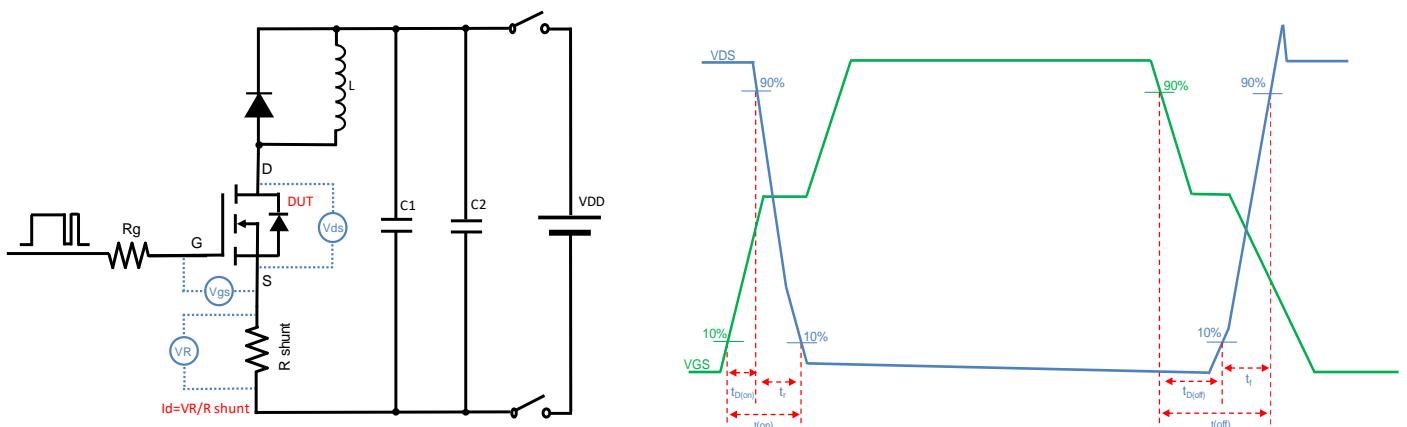


Figure C. Resistive Switching Test Circuit & Waveform

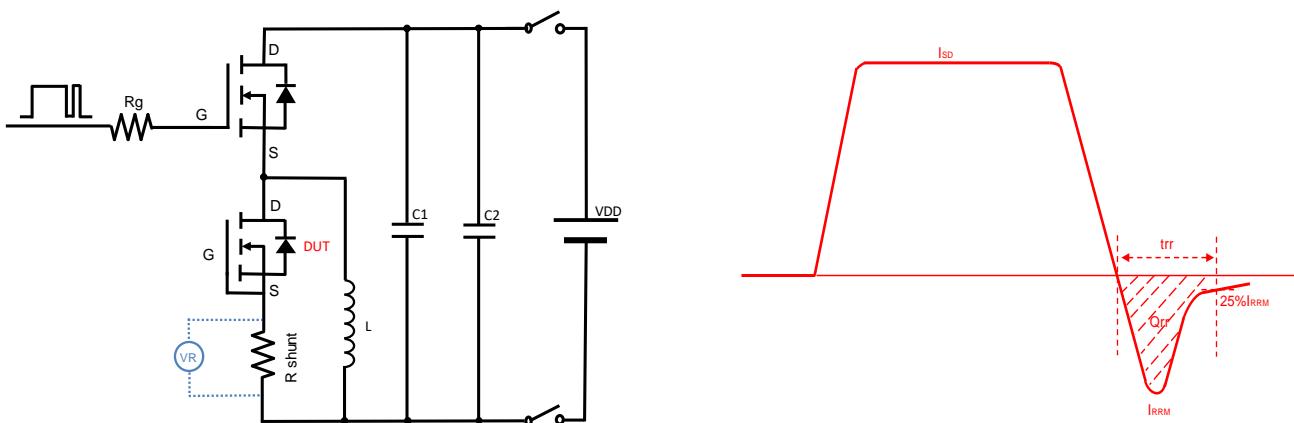
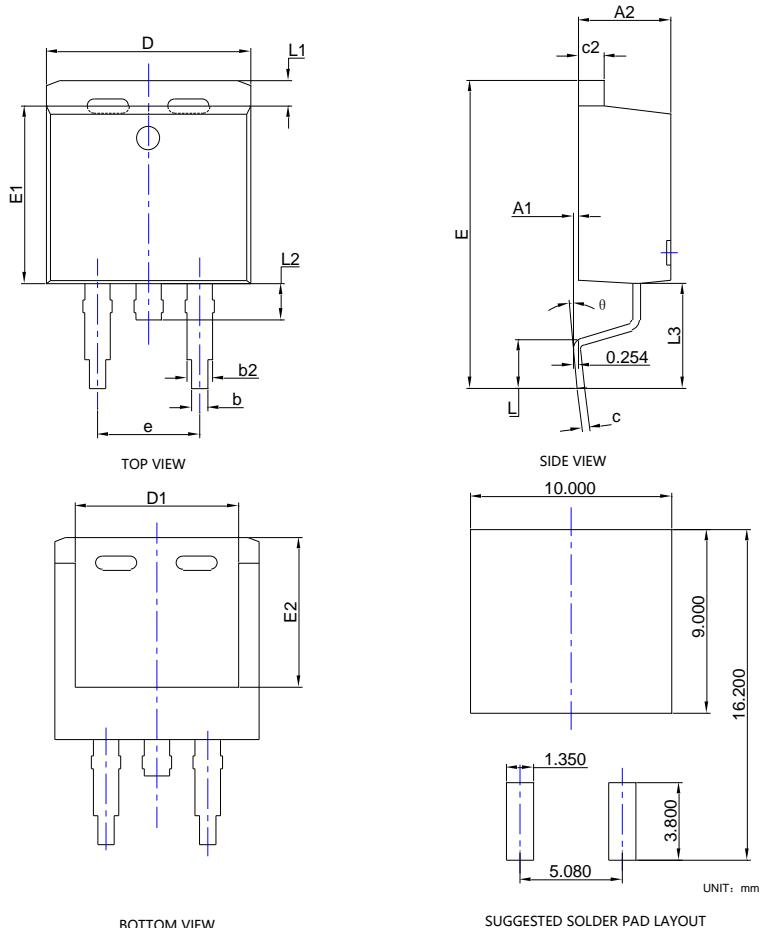


Figure D. Diode Recovery Test Circuit & Waveform



■ TO-263-B Package information

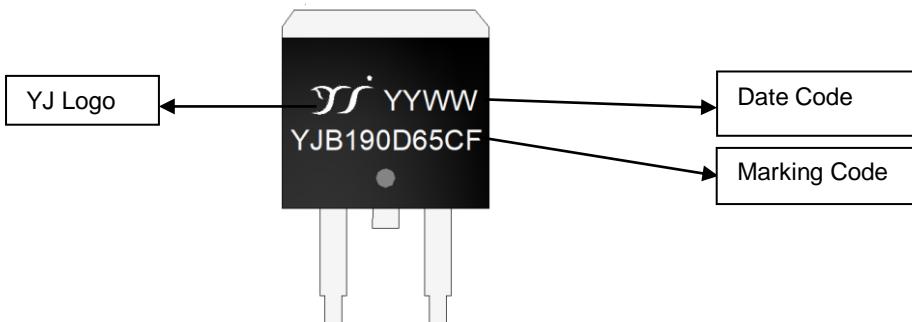


SYMBOL	INCHES		MILLIMETER	
	MIN.	MAX.	MIN.	MAX.
A1	0.000	0.010	0.000	0.254
A2	0.160	0.190	4.064	4.826
b	0.020	0.039	0.508	0.991
b2	0.045	0.070	1.143	1.778
c	0.015	0.029	0.381	0.737
c2	0.045	0.065	1.143	1.651
D	0.380	0.420	9.652	10.668
D1	0.245	---	6.223	---
E	0.575	0.625	14.605	15.875
E1	0.330	0.380	8.382	9.652
E2	0.270	---	6.858	---
e	0.200BSC		5.08BSC	
L	0.070	0.110	1.778	2.794
L1	---	0.066	---	1.676
L2	---	0.070	---	1.778
L3	0.188	0.208	4.780	5.280
θ	0°	8°	0°	8°

NOTE:
1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.
3.THE PAD LAYOUT IS FOR REFERENCE PURPOSES ONLY.



■ Marking Information



Note:

1. All marking is at middle of the product body
2. All marking is in laser printing
3. YJB190D65CF is marking code, YYWW is date code, "YY" is year, "WW" is week
4. Body color: Black



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